

ON Semiconductor®

FDB045AN08A0

N-Channel PowerTrench[®] MOSFET 75 V, 80 A, 4.5 m Ω

Features

- $R_{DS(on)}$ = 3.9 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 80 A
- $Q_{G(tot)}$ = 92 nC (Typ.) @ V_{GS} = 10 V
- · Low Miller Charge
- Low Q_{rr} Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)

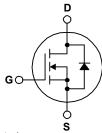
Formerly developmental type 82684

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies



D²-PAK



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	FDB045AN08A0	Units
$V_{\rm DSS}$	Drain to Source Voltage	75	V
V _{GS}	Gate to Source Voltage	±20	V
	Drain Current		
	Continuous (T _C < 137°C, V _{GS} = 10V)	90	Α
ΙD	Continuous ($T_{amb} = 25^{\circ}C$, $V_{GS} = 10V$, with $R_{\theta JA} = 43^{\circ}C/W$)	19	Α
	Pulsed	Figure 4	Α
E _{AS}	Single Pulse Avalanche Energy (Note 1)	600	mJ
	Power dissipation	310	W
P_{D}	Derate above 25°C	2.0	W/°C
T _J , T _{STG}	Operating and Storage Temperature	-55 to 175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case	0.48	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 2)	62	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient, 1in ² copper pad area	43	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB045AN08A0	FDB045AN08A0	D ² -PAK	330 mm	24 mm	800 units

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units	
Off Characteristics								
B _{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_C$	_{GS} = 0V	75	-	-	V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60V		-	-	1	μА	
		$V_{GS} = 0V$	$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	250	μΑ	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V$		-	į	±100	nA	

On Characteristics

V _{GS(TH)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	-	4	V
r _{DS(ON)}	Drain to Source On Resistance	$I_D = 80A, V_{GS} = 10V$	-	0.0039	0.0045	
		$I_D = 37A, V_{GS} = 6V$	-	0.0056	0.0084	0
		$I_D = 80A, V_{GS} = 10V,$ $T_J = 175^{\circ}C$	-	0.008	0.011	- 32

Dynamic Characteristics

C _{ISS}	Input Capacitance	V 05V V	V 05V V 0V	-	6600	-	pF
C _{OSS}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1MHz		-	1000	-	pF
C _{RSS}	Reverse Transfer Capacitance	1 = 11011 12	-	240	-	pF	
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0V \text{ to } 10V$			92	138	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0V \text{ to } 2V$	$V_{DD} = 40V$	-	11	17	nC
Q_{gs}	Gate to Source Gate Charge		$I_{D} = 80A$	-	27	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau		$I_g = 1.0 \text{mA}$	-	16	-	nC
Q_{gd}	Gate to Drain "Miller" Charge			-	21	-	nC

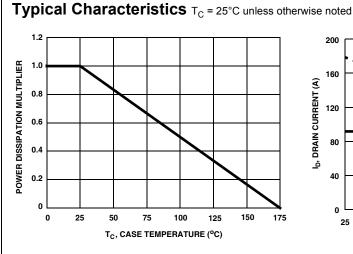
Switching Characteristics $(V_{GS} = 10V)$

t _{ON}	Turn-On Time	$V_{DD} = 40V, I_{D} = 80A$ $V_{GS} = 10V, R_{GS} = 3.3\Omega$	-	-	160	ns
t _{d(ON)}	Turn-On Delay Time		-	18	-	ns
t _r	Rise Time		-	88	-	ns
t _{d(OFF)}	Turn-Off Delay Time		-	40	-	ns
t _f	Fall Time		-	45	-	ns
t _{OFF}	Turn-Off Time		-	-	128	ns

Drain-Source Diode Characteristics

V _{SD}	Source to Drain Diode Voltage	I _{SD} = 80A	-	-	1.25	V
		I _{SD} = 40A	-	-	1.0	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 75A$, $dI_{SD}/dt = 100A/\mu s$	-	-	53	ns
Q _{RR}	Reverse Recovered Charge	I _{SD} = 75A, dI _{SD} /dt = 100A/μs	-	-	54	nC

- Notes: 1: Starting $T_J = 25^{\circ}C$, L = 0.48mH, $I_{AS} = 50A$. 2: Pulse Width = 100s



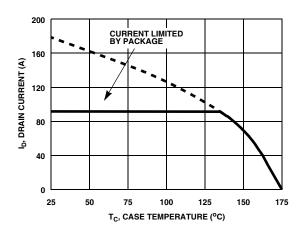


Figure 1. Normalized Power Dissipation vs
Ambient Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

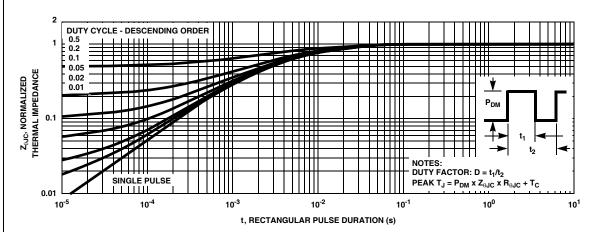


Figure 3. Normalized Maximum Transient Thermal Impedance

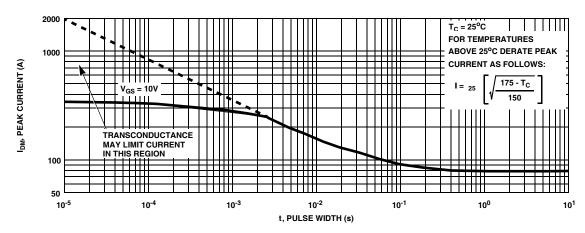


Figure 4. Peak Current Capability

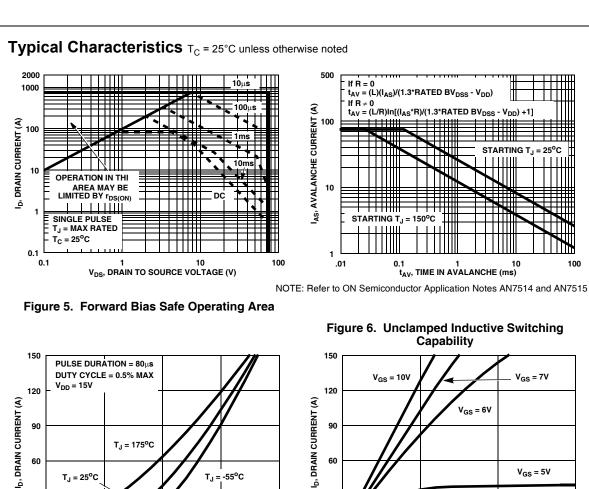


Figure 7. Transfer Characteristics

 $\begin{array}{ccc} 4.5 & 5.0 & 5.5 \\ \mathrm{V_{GS}}, \, \mathrm{GATE} \, \, \mathrm{TO} \, \, \mathrm{SOURCE} \, \, \mathrm{VOLTAGE} \, (\mathrm{V}) \end{array}$

 $T_J = 25^{\circ}C$

30

0

4.0

T_J = -55°C

6.0

PULSE DURATION = $80\mu s$ DRAIN TO SOURCE ON RESISTANCE(m\O) **DUTY CYCLE = 0.5% MAX** $V_{GS} = 6V$ V_{GS} = 10V 3 40 I_D, DRAIN CURRENT (A) 80 20

Figure 9. Drain to Source On Resistance vs Drain Current

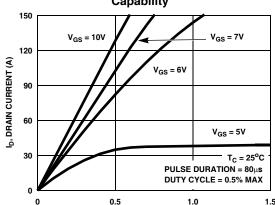


Figure 8. Saturation Characteristics

V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

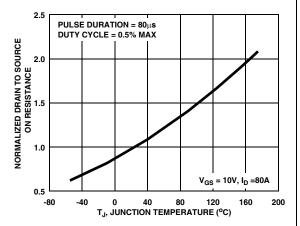


Figure 10. Normalized Drain to Source On **Resistance vs Junction Temperature**



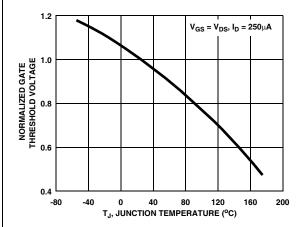


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

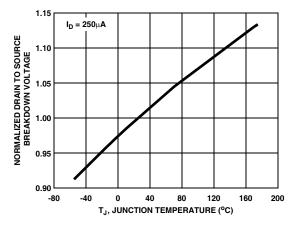


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

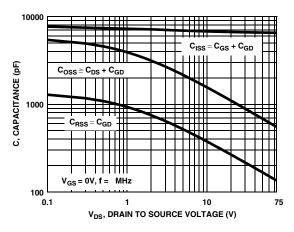


Figure 13. Capacitance vs Drain to Source Voltage

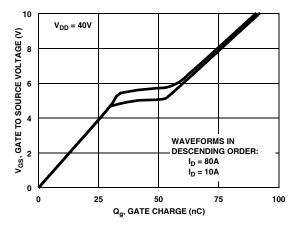


Figure 14. Gate Charge Waveforms for Constant Gate Currents

Test Circuits and Waveforms

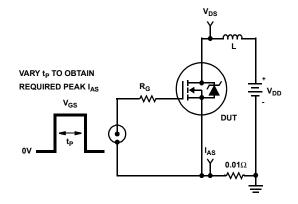


Figure 15. Unclamped Energy Test Circuit

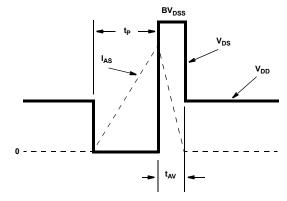


Figure 16. Unclamped Energy Waveforms

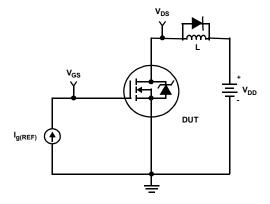


Figure 17. Gate Charge Test Circuit

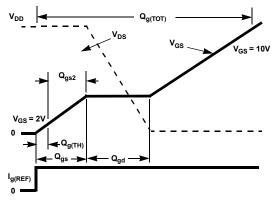


Figure 18. Gate Charge Waveforms

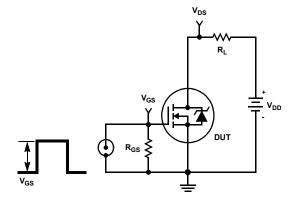


Figure 19. Switching Time Test Circuit

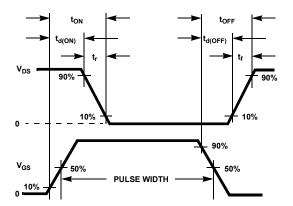


Figure 20. Switching Time Waveforms

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}} \tag{EQ. 1}$$

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
 (EQ. 2)

Area in Inches Squared

$$R_{\theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
 (EQ. 3)

Area in Centimeters Squared

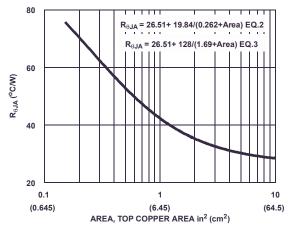
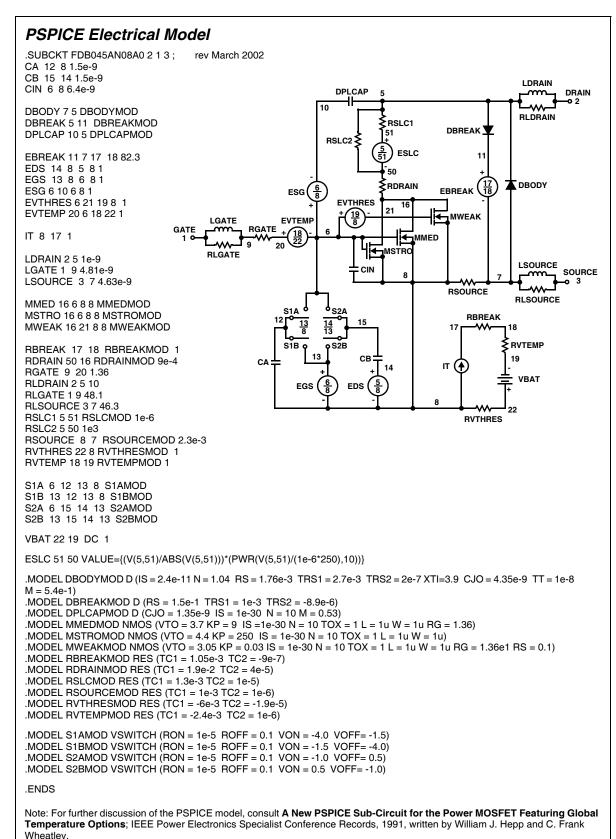


Figure 21. Thermal Resistance vs Mounting
Pad Area



SABER Electrical Model REV March 2002 template FDB045AN08A0 n2,n1,n3 electrical n2,n1,n3 var i iscl dp..model dbodymod = (isl = 2.4e-11, n1 = 1.04, rs = 1.76e-3, trs1 = 2.7e-3, trs2 = 2e-7, xti = 3.9, cjo = 4.35e-9, tt = 1e-8, m = 5.4e-1) dp..model dbreakmod = (rs = 1.5e-1, trs1 = 1e-3, trs2 = -8.9e-6) dp..model dplcapmod = (cjo = 1.35e-9, isl =10e-30, nl =10, m = 0.53) m..model mmedmod = (type=_n, vto = 3.7, kp = 9, is =1e-30, tox=1) m..model mstrongmod = $(type=_n, vto = 4.4, kp = 250, is = 1e-30, tox = 1)$ m..model mweakmod = $(type=_n, vto = 3.05, kp = 0.03, is = 1e-30, tox = 1, rs=0.1)$ sw_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -4.0, voff = -1.5) sw_vcsp..model s1bmod = (ron =1e-5, roff = 0.1, von = -1.5, voff = -4.0) $sw_vcsp..model s2amod = (ron = 1e-5, roff = 0.1, von = -1.0, voff = 0.5)$ sw_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 0.5, voff = -1.0) I DRAIN DPLCAP DRAIN 10 c.ca n12 n8 = 1.5e-9RLDRAIN c.cb n15 n14 = 1.5e-9 ERSLC1 c.cin n6 n8 = 6.4e-9RSLC2 ISCL dp.dbody n7 n5 = model=dbodymod dp.dbreak n5 n11 = model=dbreakmod DBREAK 3 50 dp.dplcap n10 n5 = model=dplcapmod **≷**RDRAIN ESG (11 DBODY i.it n8 n17 = 1 **EVTHRES** 16 1<u>9</u> MWEAK **FVTFMP** I.Idrain n2 n5 = 1e-9I GATE 18 22 I.lgate n1 n9 = 4.81e-9**EBREAK ←**MMED 20 1.1source n3 n7 = 4.63e-9 **€**MSTR RLGATE **LSOURCE** m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u CIN SOURCE m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u **RSOURCE** RLSOURCE res.rbreak n17 n18 = 1, tc1 = 1.05e-3, tc2 = -9e-7 RBREAK <u>13</u> 8 res.rdrain n50 n16 = 9e-4, tc1 = 1.9e-2, tc2 = 4e-5 17 res.rgate n9 n20 = 1.36 SIB RVTEMP res.rldrain n2 n5 = 10 res.rlgate n1 n9 = 48.1 CB 19 CA 14 IT res.rlsource n3 n7 = 46.3 VBAT res.rslc1 n5 n51= 1e-6, tc1 = 1e-3, tc2 =1e-5 8 5 8 EGS EDS res.rslc2 n5 n50 = 1e3res.rsource n8 n7 = 2.3e-3, tc1 = 1e-3, tc2 =1e-6 res.rvtemp n18 n19 = 1, tc1 = -2.4e-3, tc2 = 1e-6**RVTHRES** res.rvthres n22 n8 = 1, tc1 = -6e-3, tc2 = -1.9e-5spe.ebreak n11 n7 n17 n18 = 82.3 spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esg n6 n10 n6 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 spe.evthres n6 n21 n19 n8 = 1 sw vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/250))**10))

SPICE Thermal Model JUNCTION **REV 23 March 2002** FDB045AN08A0T CTHERM1 th 6 6.45e-3 CTHERM2 6 5 3e-2 CTHERM3 5 4 1.4e-2 CTHERM1 RTHERM1 CTHERM4 4 3 1.65e-2 CTHERM5 3 2 4.85e-2 CTHERM6 2 tl 1e-1 RTHERM1 th 6 3.24e-3 RTHERM2 6 5 8.08e-3 RTHERM3 5 4 2.28e-2 RTHERM2 CTHERM2 RTHERM4 4 3 1e-1 RTHERM5 3 2 1.1e-1 RTHERM6 2 tl 1.4e-1 5 SABER Thermal Model SABER thermal model FDB045AN08A0T RTHERM3 CTHERM3 template thermal_model th tl thermal_c th, tl ctherm.ctherm1 th 6 = 6.45e-3ctherm.ctherm2 6 5 = 3e-2 ctherm.ctherm3 5 4 = 1.4e-2ctherm.ctherm4 4 3 = 1.65e-2 ctherm.ctherm5 3 2 = 4.85e-2 RTHERM4 CTHERM4 ctherm.ctherm6 2 tl = 1e-1 rtherm.rtherm1 th 6 = 3.24e-3rtherm.rtherm2 6 5 = 8.08e-3rtherm.rtherm3 5 4 = 2.28e-2 rtherm.rtherm4 4 3 = 1e-1 rtherm.rtherm5 3 2 = 1.1e-1 RTHERM5 CTHERM5 rtherm.rtherm6 2 tl = 1.4e-1 2 RTHERM6 CTHERM6 CASE

Mechanical Dimensions

TO-263 2L (D²PAK)

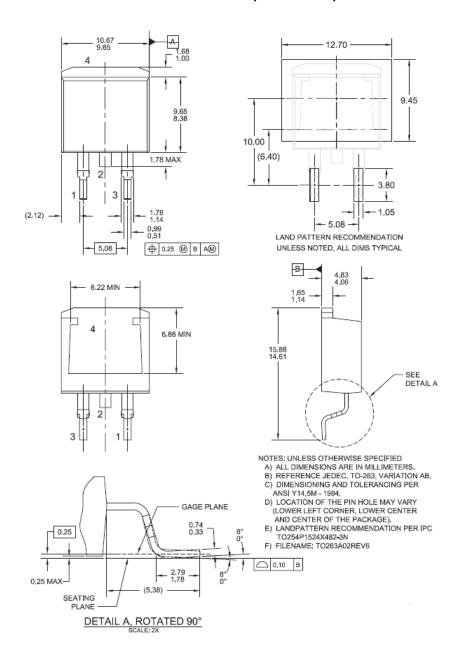


Figure 22. 2LD, TO263, Surface Mount

Package drawings are provided as a service to customers considering ON Semiconductor components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a ON Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of ON Semiconductor's worldwide terms and conditions, specifically the warranty therein, which covers ON Semiconductor products.

Dimension in Millimeters

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and h

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative